

Lect. SEDAT CANLI

Personal Information

Email: canli@metu.edu.tr

Web: <https://avesis.metu.edu.tr/canli>

International Researcher IDs

ScholarID: 6oa0C8gAAAAJ

ORCID: 0000-0003-3458-1096

Publons / Web Of Science ResearcherID: ABA-3467-2020

ScopusID: 56898984900

Yoksis Researcher ID: 164879

Education Information

Postgraduate, Middle East Technical University, Graduate School of Natural and Applied Sciences, Mikro Ve Nanoteknoloji (YI) (Tezli), Turkey 2007 - 2010

Undergraduate, Middle East Technical University, Faculty of Arts and Sciences, Department of Physics, Turkey 1999 - 2006

Foreign Languages

English, C2 Mastery

Dissertations

Postgraduate, Thickness determination of thin films by energy dispersive x-ray spectroscopy, Middle East Technical University, Graduate School of Natural and Applied Sciences, Mikro Ve Nanoteknoloji (YI) (Tezli), 2010

Academic Titles / Tasks

Lecturer, Middle East Technical University, Presidency Office, Presidency Office, 2010 - Continues

Patent

CANLI S., A thickness determination method, Patent, CHAPTER G Physics, Standard Registration, 2012

Metrics

Publication: 5

Citation (WoS): 24

Citation (Scopus): 16

H-Index (WoS): 3

H-Index (Scopus): 3